# **■ MN102L59D**

Туре	MN102L59D	MN102LF59D			
Internal ROM type	Mask ROM	FLASH			
ROM (byte)	64K				
RAM (byte)	2K				
Package (Lead-free)	LQFP064-P-1414	LQFP064-P-1414 (ES (Engineering Sample) available			
Minimum Instruction Execution Time	[With main clock operated] 100 ns (at 4.5 V to 5.5 V, 5 MHz externally, multiplied by 4 internally)				

#### Interrupts

RESET, Watchdog, Timer counter 0 to 11, External 0 to 5, Serial ch.0 transfer finish, Serial ch.1 transfer finish, /NMI pin, A/D

## ■ Timer Counter

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conversion finish
Timer counter 0 : 8-bit × 1 (timer output, event count)
  Interrupt source ...... underflow of timer counter 0
Timer counter 1 : 8-bit × 1 (timer output, event count, A/D conversion start up)
  Interrupt source ...... underflow of timer counter 1
Timer counter 2 : 8-bit \times 1 (timer output, event count)
  Clock source.....system clock; external clock; timer counter 0, 1 output
  Interrupt source ...... underflow of timer counter 2
Timer counter 3: 8-bit × 1 (interval timer, UART baud rate generator)
  Interrupt source ...... underflow of timer counter 3
Timer counter 4: 8-bit × 1 (interval timer)
  Interrupt source ...... underflow of timer counter 4
Timer counter 5 : 8-bit × 1 (interval timer)
  Interrupt source ...... underflow of timer counter 5
Timer counter 6 : 16-bit \times 1 (timer output, event count)
  Interrupt source ...... underflow of timer counter 6
Timer counter 7 : 16-bit \times 1 (timer output, event count)
  Interrupt source ...... underflow of timer counter 7
Timer counter 8 : 8-bit \times 1 (timer output, event count, simple PWM output)
  Interrupt source ...... underflow of timer counter 8
Timer counter 9 : 8-bit \times 1 (timer output, event count, simple PWM output)
  Interrupt source ...... underflow of timer counter 9
Timer counter 10: 8-bit × 1
 (timer output, simple inverter control [simple 6-phase PWM output])
  Clock source.....high-speed clock (after multiplication); 1/1, 1/2, 1/8 of system clock frequency
  Interrupt source ...... overflow of timer counter 10
Timer counter 11: 16-bit updown counter × 1
 (highly functional inverter control [simple 6-phase PWM output], A/D conversion start)
  Clock source.....high-speed clock (after multiplication); 1/1 of system clock frequency
  Interrupt source ...... overflow of timer counter 11; underflow of timer counter 11
```

Connectable timer counter 0, 1, 2 timer counter 0, 4, 5

## ■ Serial interface

 $Serial~0,~1:1~to~8-bit\times 1~(common~use~with~half-duplex~UART,~transfer~direction~of~MSB/LSB~selectable)$ 

Half-duplex UART × 2 (common use with serial 0, 1)

#### ■ I/O Pins

I/O	52.	Common use: 52 (by bit)
17 0	52	Common use: 32 (by bit)

#### ■ A/D converter

10-bit  $\times$  12-ch. (with S/H) : 4 channels for common use

#### PWM

16-bit × 2-ch. (commen use with timer counter 6,7) simple 6-phase PWM output 8-bit × 1-ch.(common use with timer counter 10) 6-phase PWM output 16-bit × 1ch. (timer counter 11)

#### Notes

6-phase PWM output support

# ■ Electrical Charactreistics (Supply current)

Parameter	Symbol	Condition	Limit			Unit
Parameter			min	typ	max	Unit
Operating supply current	IDDopr	VI = VDD or VSS, output open f = 5 MHz, VDD = 5.0 V			75	mA
Supply current at STOP	IDDS	Pin with pull-up resistor is open all other input pins and			50	μΑ
Supply current at HALT0	IDDH	Hi-Z state input/output pins are simultaneously applied VDD or VSS level f = 5 MHz, VDD = 5.0 V, output open			30	mA

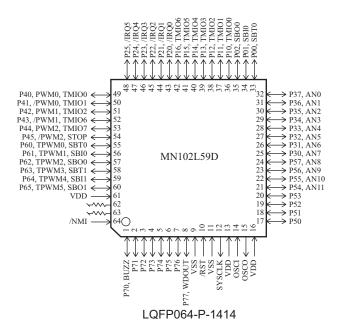
(Ta = -20°C to +85°C, VDD = 5.0V, VSS = 0V)

### ■ Development tools

In-circuit Emulator

PX-ICE102L00 + PX-PRB102L59-LQFP064-P-1414

## ■ Pin Assignment



Note) The MN102LF59D is manufactured and sold under license agreement with BULL CP8 Inc. Note that MN102LF59D cannot be used as the IC card.

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